



74AHC1G126Q

SINGLE BUFFER GATE WITH 3-STATE OUTPUT

Description

The 74AHC1G126Q is an automotive compliant single non-inverting buffer/bus driver with a 3-state output. The output enters a high impedance state when a LOW-level is applied to the output enable (OE) pin. The device is designed for operation with a power supply range of 2.0V to 5.5V.

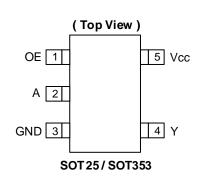
Pin Assignments

Applications

General Purpose Logic

Range

Wide Array of Products, such as:



Automotive Applications within Grade 1 Temperature

Industrial Computing/Controls/Automation

Industrial/Agricultural Equipment

High Reliability Networking/Communications

Features

- Grade 1 Ambient Temperature Operation: -40°C to +125°C
- Supply Voltage Range from 2.0V to 5.5V
- ±8mA Output Drive at 4.5V
- CMOS Low-Power Consumption
- Schmitt Trigger Action at All Inputs Make the Circuit Tolerant for Slower Input Rise and Fall Time
- Inputs Not Limited by Vcc
- Balanced Propagation Delays
- Balanced Drive Capability
- ESD Protection Tested per AEC-Q100
- Exceeds 2000-V Human Body Model (AEC-Q100-002)
- Exceeds 1000-V Charged Device Model (AEC-Q100-011)
- Latch-Up Exceeds 100mA (AEC-Q100-004)
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- The 74AHC1G126Q is suitable for automotive applications requiring specific change control; this part is AEC-Q100 qualified, PPAP capable, and manufactured in IATF 16949 certified facilities.

https://www.diodes.com/quality/product-definitions/

Notes:

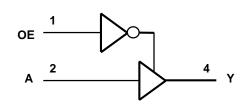
- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and
- Lead-free.
 - 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.



Pin Descriptions

Pin Name	Description
OE	Output Enable
А	Data Input
GND	Ground
Y	Data Output
Vcc	Supply Voltage

Logic Diagram



Function Table

Inp	uts	Output
OE	А	Y
Н	Н	н
L	L	L
L	Х	Z

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	kV
ESD CDM	Charged Device Model ESD Protection	1	kV
Vcc	Supply Voltage Range	-0.5 to 6.5	V
Vı	Input Voltage Range	-0.5 to 6.5	V
Vo	Voltage Applied to Output in High or Low State	-0.5 to V _{CC} + 0.5	V
Ік	Input Clamp Current VI < 0	-20	mA
Іок	Output Clamp Current (Vo < 0 or Vo > Vcc)	±20	mA
lo	Continuous Output Current (Vo = 0 to Vcc)	±25	mA
lcc	Continuous Current Through V _{CC}	75	mA
Ignd	Continuous Current Through GND	-75	mA
TJ	Operating Junction Temperature	-40 to +150	°C
TSTG	Storage Temperature	-65 to +150	°C
PD	Total Power Dissipation (Note 6)	250	mW

Absolute Maximum Patings

4. Stresses beyond the absolute maximum can result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.

5. Forcing the maximum allowed voltage could cause a condition exceeding the maximum current or conversely forcing the maximum current could cause a condition exceeding the maximum voltage. The ratings of both current and voltage must be maintained within the controlled range.

6. This will need to be derated at higher operating temperatures to prevent exceeding maximum T_J. Refer to package thermal characteristics section.

Notes:



Recommended Operating Conditions (Note 7)

Symbol	Р	arameter	Min	Max	Unit
Vcc	Operating Voltage	_	2	5.5	V
		Vcc = 2V	1.5	_	
Vih	High-Level Input Voltage	Vcc = 3V	2.1	—	V
		Vcc = 5.5V	3.85	—	
		Vcc = 2V	_	0.5	
VIL	Low-Level Input Voltage	Vcc = 3V	_	0.9	V
		Vcc = 5.5V	—	1.65	
VI	Input Voltage		0	5.5	V
Vo	Output Voltage		0	Vcc	V
		Vcc = 2V	_	-50	μA
Іон	High-Level Output Current	$V_{CC} = 3.3V \pm 0.3V$	_	-4	
		$V_{CC} = 5V \pm 0.5V$	_	-8	mA
		Vcc = 2V	_	50	μA
IOL	Low-Level Output Current	$V_{CC} = 3.3V \pm 0.3V$	_	4	
		$V_{CC} = 5V \pm 0.5V$	_	8	mA
		$V_{CC} = 3.3V \pm 0.3V$	_	100	
Δt/ΔV	Input Transition Rise or Fall Rate	$V_{CC} = 5V \pm 0.5V$	—	20	ns/V
TA	Operating Free-Air Temperature	—	-40	+125	°C

Note: 7. Unused inputs should be held at V_{CC} or Ground.

Electrical Characteristics (All typical values are at V_{CC} = 3.3V, T_A = +25°C.)

					+25°C		-40°C to	o +85°C	-40°C to	+125°C			
Symbol	Parameter	Test Conditions	Vcc	Min	Тур	Max	Min	Max	Min	Max	Unit		
		VI = VIH or VIL	2V	1.9	2	_	1.9	_	1.9	_			
		VI = VIH Or VIL Іон = -50µА	3V	2.9	3	—	2.9	—	2.9	_			
	V _{OH} High Level Output Voltage	10H = -30μΑ	4.5V	4.4	4.5	_	4.4	—	4.4	—			
Vон		VI = VIH or VIL IOH = -4mA	3V	2.58	_	_	2.48	_	2.40	_	V		
		Vı = Viн or Vil Iон = -8mA	4.5V	3.94	_	_	3.8	_	3.70	_			
	Low Level Output VoL Voltage		2V			0.1	_	0.1	_	0.1			
		$V_{I} = V_{IH} \text{ or } V_{IL}$ $I_{OL} = 50\mu A$	3V	_	_	0.1		0.1	_	0.1			
			4.5V	—	—	0.1		0.1	—	0.1			
Vol		Voltage	Voltage	$V_I = V_{IH} \text{ or } V_{IL}$ $I_{OL} = 4mA$	3V	_	_	0.36	_	0.44	_	0.55	V
			VI = VIH or VIL IOL = 8mA	4.5V	_	_	0.36	_	0.44	_	0.55		
loz	Z State Leakage Current	$V_1 = 5.5V$ or GND $V_0 = 0$ to 5.5V	5.5V	_	_	0.25	—	2.5	_	10	μΑ		
lı	Input Current	$V_I = 5.5V \text{ or } GND$	0 to 5.5V	_	_	±0.1	_	±1		±2	μA		
Icc	Supply Current	V ₁ = 5.5V or GND Io = 0	5.5V			1		10	_	40	μΑ		
Cı	Input Capacitance	$V_I = V_{CC}$ or GND	5.5V	_	2.0	10	—	10	—	10	pF		



Package Characteristics

Symbol	Parameter	Package	Test Conditions	Min	Тур	Max	Unit
0	Thermal Resistance	SOT25	Nete 0		184	_	°C/W
θJA	θ _{JA} Junction-to-Ambient	SOT353	Note 8		385	_	
0		SOT25	Niete O		62	—	00444
θις	Junction-to-Case	SOT353	Note 8	_	164	_	°C/W

Note: 8. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

Switching Characteristics

Bergmeter From	From	То	Test		+25°C		-40°C to +85°C		-40°C to +125°C		Unit
Parameter	(Input)	(Output)	Conditions	Min	Тур	Max	Min	Max	Min	Max	Unit
		A Y	C _L = 15pF	1.0	4.7	8.0	1.0	9.5	1.0	11.5	ns
t _{PD} A	A		C _L = 50pF	1.0	6.6	11.5	1.0	13.0	1.0	14.5	ns
	OE	V	C _L = 15pF	1.0	5.0	8.0	1.0	9.5	1.0	11.5	ns
t _{EN}	UE	ř	C _L = 50pF	1.0	6.9	11.5	1.0	13.0	1.0	14.5	ns
4	OE	V	$C_L = 15 pF$	1.0	6.0	9.7	1.0	11.5	1.0	12.5	ns
tDIS OE	UE	JE Y	$C_L = 50 pF$	1.0	8.3	13.2	1.0	15.0	1.0	16.5	ns

Vcc = 5V ± 0.5V (See Figure 1)

Parameter	From	То	To Test		+25°C		-40°C to +85°C		-40°C to +125°C		Unit		
Parameter	(Input)	(Output)	Conditions	Min	Тур	Max	Min	Max	Min	Max	Unit		
4		V	C _L = 15pF	1.0	3.4	5.5	1.0	6.5	1.0	7.0	ns		
t _{PD} A	A	T	$C_L = 50 pF$	1.0	4.8	7.5	1.0	8.5	1.0	9.5	ns		
4			ten OE	V	$C_L = 15 pF$	1.0	3.6	5.1	1.0	6.0	1.0	6.5	ns
ten	UE	UE Y	$C_L = 50 pF$	1.0	4.9	7.5	1.0	8.5	1.0	9.5	ns		
t= 10	OF		$C_L = 15 pF$	1.0	4.1	6.8	1.0	8.0	1.0	8.5	ns		
tdis OE	Y	$C_L = 50 pF$	1.0	5.7	8.8	1.0	10.0	1.0	11.0	ns			

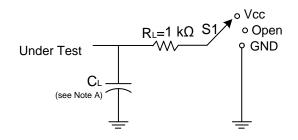
Operating Characteristics

T_A = +25°C

	Parameter	Test Conditions	V _{CC} = 5V Typ	Unit
CPD	Power Dissipation Capacitance	f = 1MHz No Load	10	pF



Measurement Information

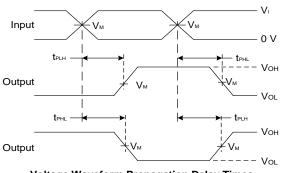


Test	S1
tplH/tpHL	Open
t _{PLZ} /t _{PZL}	V _{LOAD}
t _{PHZ} /t _{PZH}	GND

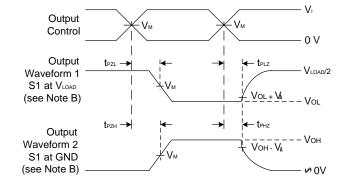
Vee	In	puts	Ver	C.	MA
Vcc	VI	t _R /t _F	νм	C∟	VΔ
3.3V±0.3V	Vcc	≤3ns	V _{CC} /2	15pF	0.3V
5V±0.5V	Vcc	≤3ns	Vcc/2	15pF	0.3V
3.3V±0.3V	Vcc	≤3ns	V _{CC} /2	50pF	0.3V
5V±0.5V	Vcc	≤3ns	Vcc/2	50pF	0.3V



Voltage Waveform Pulse Duration







Voltage Waveform Enable and Disable Times Low and High Level Enabling

Figure 1. Load Circuit and Voltage Waveforms

A. Includes test lead and test apparatus capacitance. Notes:

B. All pulses are supplied at pulse repetition rate ≤ 1MHz.
C. Inputs are measured separately one transition per measurement.

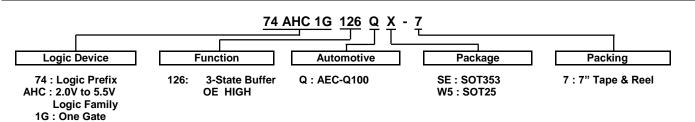
D. t_{PLZ} and t_{PHZ} are the same as t_{DIS}.

E. t_{PZL} and t_{PZH} are the same as t_{EN}.

F. t_{PLH} and t_{PHL} are the same as t_{PD} .



Ordering Information (Note 9)

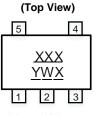


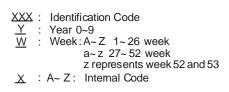
Part Number	Package Package		Package Size	7" Tape and Reel		
Fait Nulliber	Code	(Notes 10 & 11)	Fackage Size	Quantity	Part Number Suffix	
74AHC1G126QSE-7	SE	SOT353	2.15mm × 2.1 mm × 1.1 mm 0.65mm lead pitch	3000/Tape & Reel	-7	
74AHC1G126QW5-7	W5	SOT25	3.0mm × 2.8mm × 1.2mm 0.95mm lead pitch	3000/Tape & Reel	-7	

Notes: 9. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

10. Pad layout as shown in Diodes Incorporated's package outline PDFs, which can be found on our website at http://www.diodes.com/package-outlines.html. 11. The taping orientation is located on our website at https://www.diodes.com/assets/Packaging-Support-Docs/ap02007.pdf.

Marking Information





SOT 25 / SOT 353

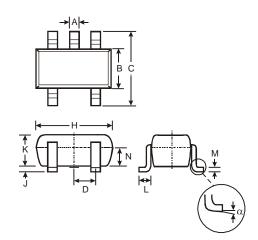
Part Number	Package	Identification Code
74AHC1G126QW5-7	SOT25	YZQ
74AHC1G126QSE-7	SOT353	YZQ



Package Outline Dimensions

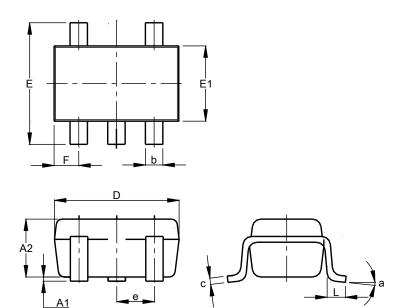
Please see http://www.diodes.com/package-outlines.html for the latest version.

(1) Package Type: SOT25



SOT25				
Dim	Min	Max	Тур	
Α	0.35	0.50	0.38	
в	1.50	1.70	1.60	
С	2.70	3.00	2.80	
D	-	-	0.95	
н	2.90	3.10	3.00	
J	0.013	0.10	0.05	
К	1.00	1.30	1.10	
L	0.35	0.55	0.40	
М	0.10	0.20	0.15	
Ν	0.70	0.80	0.75	
α	0°	8°	-	
All Dimensions in mm				

(2) Package Type: SOT353



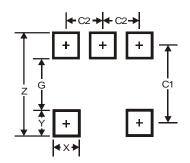
SOT353				
Dim	Min	Max	Тур	
A1	0.00	0.10	0.05	
A2	0.90	1.00	0.95	
b	0.10	0.30	0.25	
С	0.10	0.22	0.11	
D	1.80	2.20	2.15	
E	2.00	2.20	2.10	
E1	1.15	1.35	1.30	
е	0.650 BSC			
F	0.40	0.45	0.425	
L	0.25	0.40	0.30	
а	0°	8°		
All Dimensions in mm				



Suggested Pad Layout

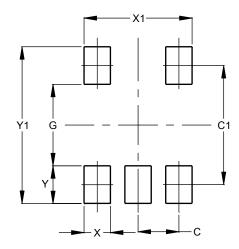
Please see http://www.diodes.com/package-outlines.html for the latest version.

(1) Package Type: SOT25



Dimensions	Value
Z	3.20
G	1.60
Х	0.55
Y	0.80
C1	2.40
C2	0.95

(2) Package Type: SOT353



Dimensions	Value (in mm)
С	0.650
C1	1.900
G	1.300
Х	0.420
X1	1.720
Ý	0.600
Y1	2.500

Mechanical Data

SOT25

- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Plated Leads, Solderable per MIL-STD-202, Method 208
- Weight: 0.0158 grams (Approximate)

SOT353

- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Plated Leads, Solderable per MIL-STD-202, Method 208 3
- Weight: 0.0064 grams (Approximate)



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